

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 19.0009
CB Certificate No.: 50600264 ITL

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Appendix-1 (50600264 ITL) Schedule of Scope to Certificate of Approval

Test Items	Standard/Method
Drop Test	ISTA 1,2A (ATP-03-10-0089)
High Temperature Operation Test	JESD22-A108 (ATP-03-10-0090)
High Temperature Storage Test	JESD22-A103 (ATP-03-10-0090)
Low Temperature Operation Test	JESD22-A108 (ATP-03-10-0095)
Low Temperature Storage Test	JESD22-A119 (ATP-03-10-0095)
Temperature and Humidity Test	IEC60068-2-78 (ATP-03-10-0099)
Temperature Cycling Test	JESD22-A104 (ATP-03-10-0098)

Michael Chou

Technical Reviewer of DQS:

Date: 1/12/2021

